PH955L

N-channel TrenchMOS logic level FET

Rev. 02 — 19 February 2009

Product data sheet

1. Product profile

1.1 General description

Logic level N-channel enhancement mode Field-Effect Transistor (FET) in a plastic package using TrenchMOS technology. This product is designed and qualified for use in computing, communications, consumer and industrial applications only.

1.2 Features and benefits

Low conduction losses due to low on-state resistance

1.3 Applications

- DC-to-DC convertors
- General purpose power switching

1.4 Quick reference data

- Suitable for logic level gate drive sources
- Motors, lamps and solenoids
- Portable equipment

Table 1.	Quick reference					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V _{DS}	drain-source voltage	T _j ≥ 25 °C; T _j ≤ 150 °C	-	-	55	V
I _D	drain current	T _{mb} = 25 °C; V _{GS} = 5 V; see <u>Figure 1</u> ; see <u>Figure 3</u>	-	-	62.5	А
P _{tot}	total power dissipation	T _{mb} = 25 °C; see <u>Figure 2</u>	-	-	62.5	W
Dynamic	characteristics					
Q _{GD}	gate-drain charge	$V_{GS} = 5 V; I_D = 25 A;$ $V_{DS} = 44 V; T_j = 25 °C;$ see <u>Figure 11</u> ; see <u>Figure 12</u>	-	16.4	-	nC
Static ch	aracteristics					
R _{DSon}	drain-source on-state resistance	V_{GS} = 10 V; I_D = 25 A; T_j = 25 °C; see <u>Figure 10</u>	-	6.2	8.3	mΩ



2. Pinning information

Table 2.	Pinning	information		
Pin	Symbol	Description	Simplified outline	Graphic symbol
1	S	source		_
2	S	source	mb	
3	S	source		
4	G	gate	q	
mb	D	mounting base; connected to drain	$\begin{array}{c} \hline \\ \hline \\ 1 \end{array} \begin{array}{c} 2 \end{array} \begin{array}{c} 3 \end{array} \begin{array}{c} 4 \end{array}$	mbb076 S
			SOT669 (LFPAK)	

3. Ordering information

Table 3. Ordering information Type number Package Name Description Version PH955L LFPAK plastic single-ended surface-mounted package (LFPAK); 4 leads SOT669

4. Limiting values

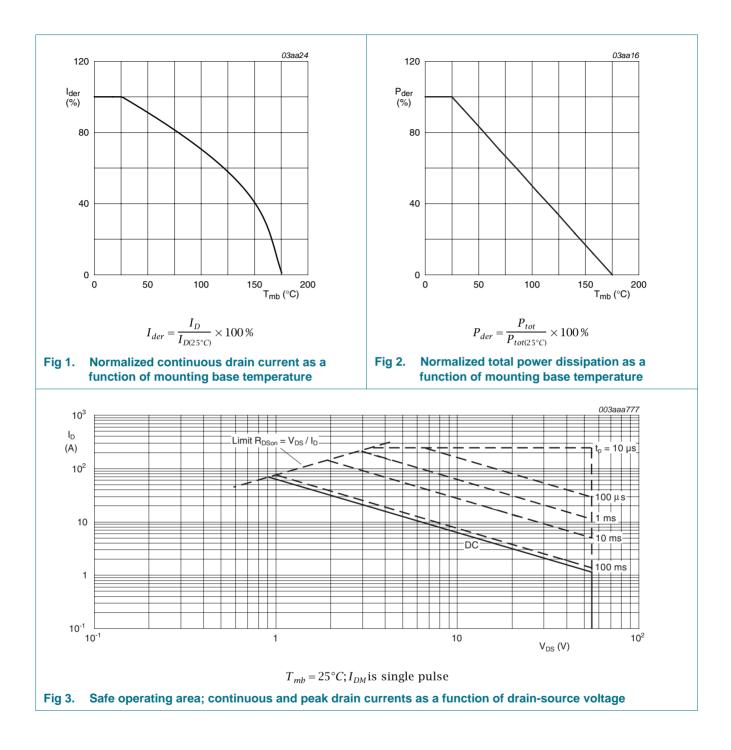
Table 4.Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Cumple of	Deveneter	Conditions		N/1:	Max	11
Symbol	Parameter	Conditions		Min	Max	Unit
V _{DS}	drain-source voltage	T _j ≥ 25 °C; T _j ≤ 150 °C		-	55	V
V_{DGR}	drain-gate voltage	$T_j \ge 25 \text{ °C}; T_j \le 150 \text{ °C}; R_{GS} = 20 \text{ k}\Omega$		-	55	V
V_{GS}	gate-source voltage			-20	20	V
I _D	drain current	$V_{GS} = 5 \text{ V}; \text{ T}_{mb} = 100 \text{ °C}; \text{ see } \frac{\text{Figure 1}}{1}$		-	43.7	А
		$V_{GS} = 5 \text{ V}; T_{mb} = 25 \text{ °C}; \text{ see } Figure 1; \text{ see } Figure 3$		-	62.5	А
I _{DM}	peak drain current	$t_p \le 10 \ \mu s$; pulsed; $T_{mb} = 25 \ ^{\circ}C$; see Figure 3		-	187	А
P _{tot}	total power dissipation	T _{mb} = 25 °C; see <u>Figure 2</u>		-	62.5	W
T _{stg}	storage temperature			-55	150	°C
Tj	junction temperature			-55	150	°C
Source-dra	ain diode					
I _S	source current	T _{mb} = 25 °C		-	52	А
I _{SM}	peak source current	$t_p \le 10 \ \mu s$; pulsed; $T_{mb} = 25 \ ^{\circ}C$		-	156	А
Avalanche	ruggedness					
E _{DS(AL)R}	repetitive drain-source avalanche energy	V_{GS} = 5 V; I_D = 4.4 A; V_{sup} \leq 55 V; unclamped; t_p = 0.1 ms; R_{GS} = 50 Ω	[1][2]	-	2	mJ
E _{DS(AL)S}	non-repetitive drain-source avalanche energy	V_{GS} = 5 V; $T_{j(init)}$ = 25 °C; I_D = 44 A; V_{sup} ≤ 55 V; unclamped; t_p = 0.1 ms; R_{GS} = 50 Ω		-	195	mJ

[1] Duty cycle is limited by the maximum junction temperature.

[2] Repetitive avalanche failure is not determined simply by thermal effects. Repetitive avalanche transients should only be applied for short bursts, not every switching cycle.

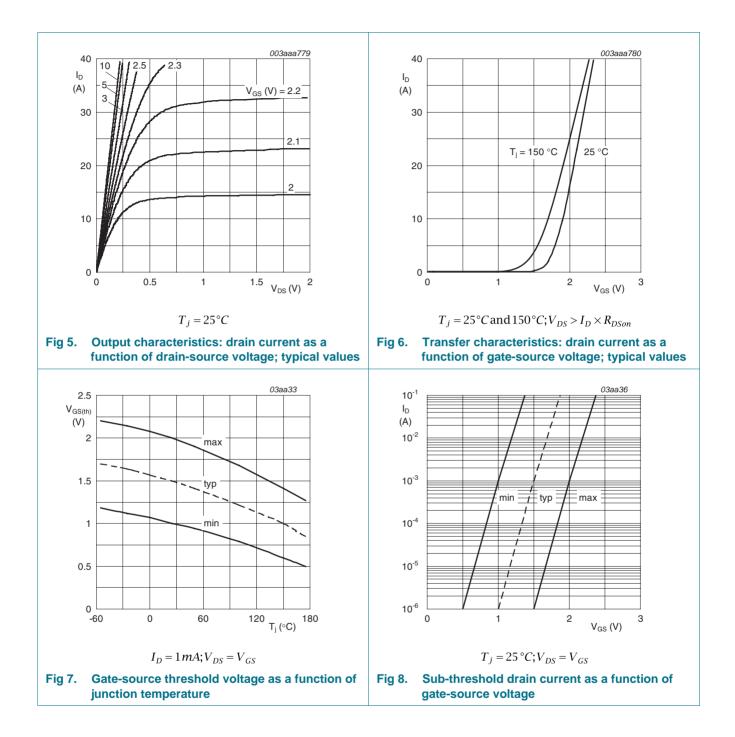


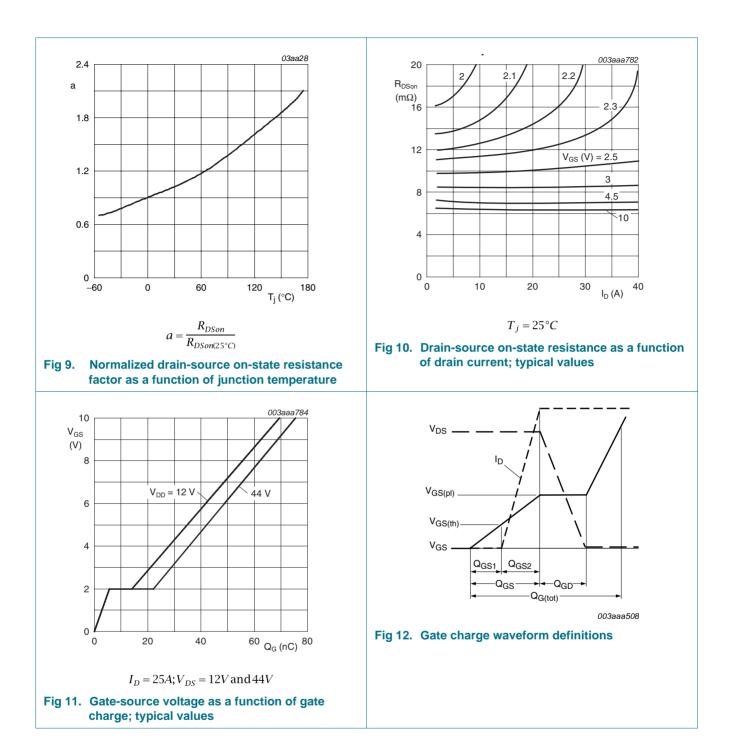
5. Thermal characteristics

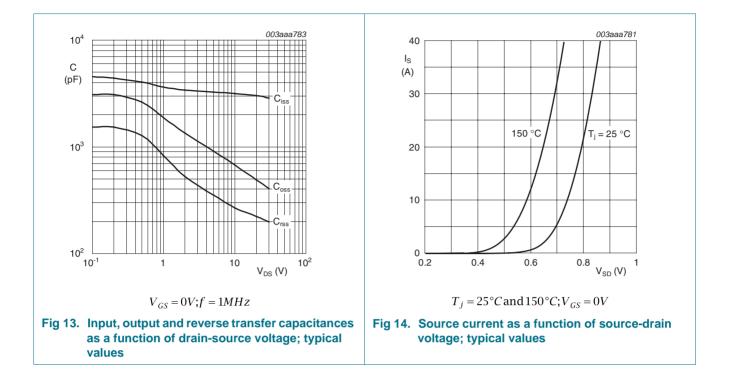
Symbol	Parameter	Conditions		Min	Тур	Max	Unit
₹ _{th(j-mb)}	thermal resistance from junction to mounting base	see <u>Figure 4</u>			-	2	K/W
10						003aaa778	
10 Z _{th(j-mb)}							
(K/W) 1	δ = 0.5						
	0.2						
10 ⁻¹	0.02						
10 ⁻²				P		$\delta = \frac{t_p}{T}$	
					→ t _p +		
10 ⁻³ 10) ⁻⁵ 10 ⁻⁴	10 ⁻³	10 ⁻²	10 ⁻¹	- −⊺-		
		10	10	10	t _p (s) '	

6. Characteristics

Table 6.	Characteristics					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static cha	aracteristics					
V _{(BR)DSS}	drain-source	I_D = 250 µA; V_{GS} = 0 V; T_j = -55 °C	50	-	-	V
	breakdown voltage	$I_D = 250 \ \mu\text{A}; \ V_{GS} = 0 \ V; \ T_j = 25 \ ^\circ\text{C}$	55	-	-	V
V _{GS(th)}	gate-source threshold voltage	$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = -55 \text{ °C};$ see <u>Figure 7</u> ; see <u>Figure 8</u>	-	-	2.3	V
		I _D = 1 mA; V _{DS} = V _{GS} ; T _j = 150 °C; see <u>Figure 7</u> ; see <u>Figure 8</u>	0.5	-	-	V
		I _D = 1 mA; V _{DS} = V _{GS} ; T _j = 25 °C; see <u>Figure 7</u> ; see <u>Figure 8</u>	1	1.5	2	V
I _{DSS}	drain leakage current	V _{DS} = 55 V; V _{GS} = 0 V; T _j = 25 °C	-	0.02	1	μA
		V _{DS} = 55 V; V _{GS} = 0 V; T _j = 150 °C	-	-	500	μA
I _{GSS}	gate leakage current	V _{GS} = 15 V; V _{DS} = 0 V; T _j = 25 °C	-	2	100	nA
		V _{GS} = -15 V; V _{DS} = 0 V; T _j = 25 °C	-	2	100	nA
R _{DSon}	drain-source on-state resistance	$V_{GS} = 4.5 \text{ V}; I_D = 25 \text{ A}; T_j = 25 \text{ °C}$	-	7.1	9.9	mΩ
		$V_{GS} = 10 \text{ V}; I_D = 25 \text{ A}; T_j = 150 \text{ °C};$ see Figure 9	-	-	16	mΩ
		V _{GS} = 10 V; I _D = 25 A; T _j = 25 °C; see <u>Figure 10</u>	-	6.2	8.3	mΩ
Dynamic	characteristics					
Q _{G(tot)}	total gate charge	$I_D = 25 \text{ A}; V_{DS} = 44 \text{ V}; V_{GS} = 5 \text{ V};$	-	42	-	nC
Q _{GS}	gate-source charge	$T_j = 25 \text{ °C}; \text{ see } Figure 11; \text{ see } Figure 12$	-	5.7	-	nC
Q _{GS1}	pre-threshold gate-source charge		-	4.3	-	nC
Q _{GS2}	post-threshold gate-source charge		-	1.4	-	nC
Q _{GD}	gate-drain charge		-	16.4	-	nC
V _{GS(pl)}	gate-source plateau voltage	$I_D = 25 \text{ A}; V_{DS} = 44 \text{ V}; T_j = 25 \text{ °C};$ see Figure 11; see Figure 12	-	2	-	V
C _{iss}	input capacitance	V _{DS} = 25 V; V _{GS} = 0 V; f = 1 MHz;	-	2836	-	pF
C _{oss}	output capacitance	T _j = 25 °C; see <u>Figure 13</u>	-	441	-	pF
C _{rss}	reverse transfer capacitance		-	210	-	pF
t _{d(on)}	turn-on delay time	V_{DS} = 25 V; R_L = 1 Ω ; V_{GS} = 5 V;	-	18	-	ns
t _r	rise time	$R_{G(ext)} = 4.7 \ \Omega; T_j = 25 \ ^{\circ}C$	-	71	-	ns
t _{d(off)}	turn-off delay time		-	105	-	ns
t _f	fall time		-	25	-	ns
Source-d	rain diode					
V _{SD}	source-drain voltage	$I_S = 25 \text{ A}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C};$ see Figure 14	-	0.85	1.2	V
t _{rr}	reverse recovery time	I _S = 20 A; dI _S /dt = -100 A/µs; V _{GS} = 0 V;	-	62	-	ns
Q _r	recovered charge	V _{DS} = 30 V; T _j = 25 °C	-	48	-	nC







7. Package outline

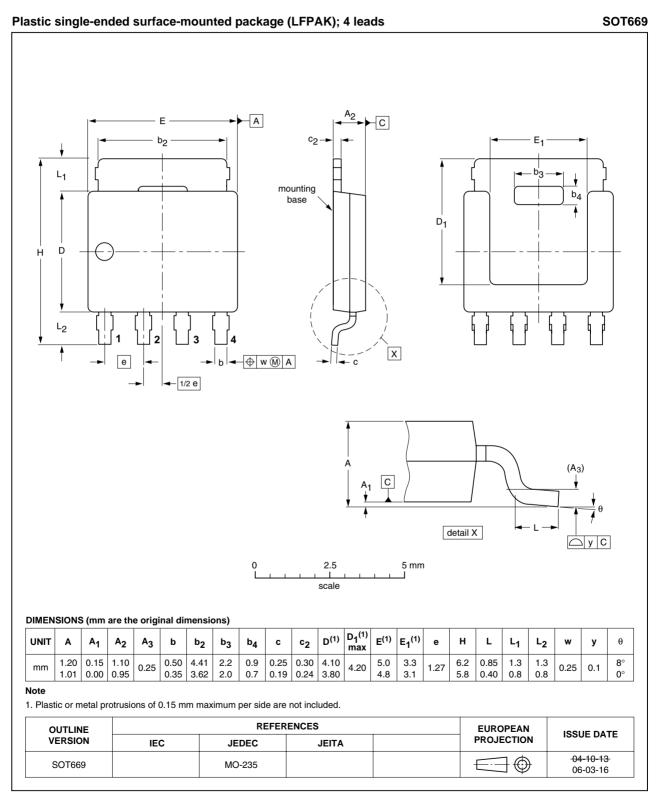


Fig 15. Package outline SOT669 (LFPAK)

8. Revision history

Table 7. Revision hi	story			
Document ID	Release date	Data sheet status	Change notice	Supersedes
PH955L_2	20090219	Product data sheet	-	PH955L_1
Modifications:		t of this data sheet has be of NXP Semiconductors.	•	y with the new identity
	 Legal texts 	have been adapted to the	ne new company name w	/here appropriate.
PH955L_1 (9397 750 14557)	20050301	Product data sheet	-	-

9. Legal information

9.1 Data sheet status

Document status [1][2]	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions"

[3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL http://www.nxp.com.

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Date of release: 19 February 2009 Document identifier: PH955L_2

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